


<b>Search Notes</b>  	<b>Application/Control No.</b>  09844187	<b>Applicant(s)/Patent Under Reexamination</b>  BAER ET AL.
	<b>Examiner</b>  Jan M Ludlow	<b>Art Unit</b>  1797

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
updated search	6/9/2008	jml
updated search	3/2/2009	jml

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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